SERIAL NO. ATTY DOCKET NO. 721561 END920030091US1 INFORMATION DISCLOSURE CITATION Krishnendu Mondal et al. (Use several sheets if necessary) GROUP FILING 2863 25/2003 **U.S. PATENT DOCUMENTS** *EXAMINER FILING DATE CLASS SUBCLASS DOCUMENT NUMBER DATE NAME IF APPROPRIATE INITIAL 714 6/2003 Park et al. 710 6,574,757 733 6,560,740 5/2003 Zuraski, Jr. et al. 714 1/2003 Cowan et al. 6,505,324 36*5* 10/2002 Hsu et al. 6,469,949 22*5.* 7 6/2002 Bhavsar et al. 6,408,401 714 718 6,405,331 6/2002 Chien TL 6,367,042 4/2002 Phan et al. 714 733 π 1/2001 6,182,257 Gillingham 733 10/2000 Kirihata et al. 6,141,267 36*5* 206 6,073,258 6/2000 Wheater 718 718 5,841,784 11/1998 Chan et al. 714 TL**FOREIGN PATENT DOCUMENTS** TRANSLATION COUNTRY CLASS SUBCLASS DOCUMENT NUMBER DATE YES NO OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Barth et al., METHOD TO REDUCE CHIP YIELD LOSS DUE TO FUSES INCORRECTLY BLOWN, Research Disclosure, May 1990, Number 313, 1 page. IBM Technical Disclosure Bulletin R. J. Prilik, Vol. 30, No. 11, April 1988, REPAIR CALCULATION FOR RANDOM-ACCESS MEMORY REDUNDANCY USING BUILT-IN LOGIC AND SCANNABLE LATCHES, pages

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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